CLAIMS

- A crystalline material characterized in that it does not contain fluorides, with a composition in a roasted state corresponding to that of the material called ITQ-17 and in that it has a composition on an anhydrous base and in terms of moles of oxides upon being synthesized, unroasted, represented by: xX_2O_3 : $(1-z)YO_2$: $zGeO_2$: r/n R_nO
- wherein:
 - X is at least one trivalent element,
- Y is one or more tetravalent elements other than germanium,
 - R is an organic structure directing compound,
- x varies between 0 and 0.02, preferably between 0 and 0.01,
- z is comprised between 0.02 and 0.67, preferably between 0.04 and 0.5,
- r varies between 0.01 and 0.5, preferably between 0.01 and 0.25, and
 - n is 1 or 2,

and whose most representative values of the X-ray diffraction angle are the following:

$2\Theta \pm 0.5$ (degrees)	Intensity (I/Io)
6.89	w, m
9.57	vs
19.35	m
21.37	m
21 90	VS

vs: very strong, m: medium, w: weak.

A crystalline material according to claim 1, whose composition on an anhydrous base and in terms of moles of oxide upon being synthesized, unroasted, may be represented by:

 $xX_{,}O_{,}$: $tTO_{,}$ $(1-z-t)SiO_{,}$: $zGeO_{,}$: r/n $R_{,}O$

wherein:

- T is one or more tetravalent elements other than Ge or Si,
- t varies between 0 and 0.15, preferably between 0 and 0.10,
- z is comprised between 0.02 and 0.67, preferably between 0.04 and 0.5, and "x", "X", "R", "r" and "n" have the meaning given in claim 1.
- 3. A crystalline material according to claim 1 or 2, wherein R is the cation 1-methyl-4-aza,1-azoniumbicyclo [2.2.2] octane (DABMe $^{+}$).
- 4. A crystalline material according to claim 1 or 2, wherein R is the cation 1,4-bis[N-(4-aza,1-azoniumbicyclo~[2,2,2]~octane) methyl]benzene (d-DABBz)²⁺.
- 5. A crystalline material according to claim 1 wherein Y is one or more tetravalent elements selected among Si, Sn, Ti and V.
- 6. A crystalline material according to claim 1 wherein Y is Si.
- 7. A crystalline material according to claim 1 or 2, wherein X is one or more trivalent elements selected from the group consisting of B, Al, In, Ga, Fe and Cr.
- 8. A crystalline material according to claim 2, wherein T is one or more tetravalent elements selected between V, Sn and Ti.
- 9. A crystalline material according to claim 2, whose composition expressed in molar ratios is the following:

- $ROH/(SiO_2+GeO_2+TO_2)$ is between 0.5 and 0.01, preferably between 0.25 and 0.01
- $\rm{GeO_2/(SiO_2+GeO_2+TO_2)}$ is between 0.67 and 0.02, preferably between 0.5 and 0.04
- $(SiO_2+GeO_2+TO_2)/X_2O_3$ is between ∞ and 50, preferably between ∞ and 100
- $TO_2/(SiO_2+GeO_2+TO_2)$ is between 0.15 and 0, preferably between 0.1 and 0.
- 10. A crystalline material according to claim 2, whose composition expressed in molar ratios is the following:
- $R(OH)_2/(SiO_2+GeO_2+TO_2)$: between 0.25 and 0.005, preferably between 0.125 and 0.005
- $GeO_2/(SiO_2+GeO_2+TO_2)$: between 0.67 and 0.02, preferably between 0.5 and 0.04
- $(SiO_2+GeO_2+TO_2)/X_2O_3$: between ∞ and 50, preferably between ∞ and 100
- $TO_2/(SiO_2+GeO_2+TO_2)$: between 0.15 and 0, preferably between 0.1 and 0.
- 11. A process for synthesizing a crystalline material that does not contain fluorides, with a composition in a roasted state corresponding to that of the material called ITQ-17 and in that it has a composition on an anhydrous base and in terms of moles of oxides upon being synthesized, unroasted, represented by:

 xX_2O_3 : $(1-z)YO_2$: $zGeO_2$: r/n R_nO wherein:

- X is at least one trivalent element,
- Y is one or more tetravalent elements other than germanium,
 - R is an organic structure directing compound,
- x varies between 0 and 0.02, preferably between 0 and 0.01,

- z is comprised between 0.02 and 0.67, preferably between 0.04 and 0.5,
- r varies between 0.01 and 0.5, preferably between 0.01 and 0.25, and
 - n is 1 or 2,

and whose most representative values of the X-ray diffraction angle are the following:

$2\Theta \pm 0.5$ (degrees)	Intensity (I/Io)
6.89	w, m
9.57	vs
19.35	m
21.37	m
21.90	vs

vs: very strong, m: medium, w: weak,
and whose process comprises:

- a) preparing a synthesis mixture that comprises at least:
- a source of one or several tetravalent elements included under the name Y,
 - a source of Ge,
- $\ \ -$ a source of at least one structure directing agent, and
 - water;
- b) keeping the synthesis mixture at temperatures between 100 and 200°C, until the crystalline material is formed and
 - c) recovering the crystalline material.
- 12. A process according to claim 11, wherein the source of germanium and of the rest of the tetravalent elements is an oxide.
- 13. A process according to claim 11, wherein the synthesis mixture also comprises a source selected among:
 - a source of one or more trivalent elements, X,

- a source of one or more tetravalent elements other than Si and Ge, and
 - a mixture of both.
- 14. A process according to claim 11, wherein the source of the structure directing agent, R, is 1-methyl-4-aza,1-azoniumbicyclo [2,2,2] octane hydroxide (DABMeOH), and wherein the synthesis mixture has a composition expressed in terms of molar ratios in the following intervals:
- $\rm H_2O/(YO_2 + GeO_2)$: between 100 and 0.01, preferably between 50 and 0.1,
- $OH^{-}/YO_{2}+GeO_{2}$) : between 3 and 0.01, preferably between 1 and 0.03,
- $R/(YO_2+GeO_2)$: between 3 and 0.01, preferably between 1 and 0.03,
- $\rm{GeO_2/(YO_2+GeO_2)}$: between 0.67 and 0.02, preferably between 0.5 and 0.04, and
- $(YO_2+GeO_2)/X_2O_3$: between ∞ and 50, preferably between ∞ and 100.
- 15. A process according to claim 11, wherein the source of the structure directing agent, R, is 1,4-bis[N-(4-aza,1-azoniumbicyclo [2,2,2] octane) methyl]benzene hydroxide (d-DABBz(OH) $_2$), and wherein the synthesis mixture has a composition expressed in terms of molar ratios in the following intervals:
- $\rm H_2O/\left(YO_2 + GeO_2\right)$: between 100 and 0.01, preferably between 50 and 0.1,
- $\ \mathrm{OH^{\text{-}}/YO_2 + GeO_2})$: between 3 and 0.01, preferably between 1 and 0.03,
- $R/(YO_2+GeO_2)$: between 1.5 and 0.005, preferably between 0.5 and 0.015,
- $\rm{GeO_2/YO_2+GeO_2}$) : between 0.657 and 0.02, preferably between 0.5 and 0.04,
 - $(YO_2+GeO_2)/X_2O_3$: between ∞ and 50, preferably

between ∞ and 100.

16. A process according to claim 11, for preparing a material whose composition may be represented by the formula:

 xX_2O_3 : tTO_2 : $(1-z-t)SiO_2$: $zGeO_2$: r/n R_nO wherein:

- T is one or more tetravalent elements other than Ge or Si,
- t varies between 0 and 0.15, preferably between 0 and 0.10,
- z is comprised between 0.02 and 0.67, preferably between 0.04 and 0.5, and "x", "X", "R", "r" and "n" have the meaning given in claim 1, that comprises:
- a) preparing a synthesis mixture that comprises at least:
 - a source of silicon,
 - a source of Ge, and
- a source of at least one structure directing agent (R) and $% \left(\frac{1}{2}\right) =0$
 - water
- b) keeping the synthesis mixture at temperatures between 100 and 200°C, until the crystalline material is formed and
 - c) recovering the crystalline material.
- 17. A process according to claim 16, wherein the source of the structure directing agent (R) is 1-methyl-4-aza,1-azoniumbicyclo [2,2,2] octane hydroxide (DABMeOH), and wherein the synthesis mixture has a composition expressed in terms of molar ratios in the following intervals:
- $\rm H_2O/(SiO_2+GeO_2+TO_2)$: between 100 and 0.01, preferably between 50 and 0.1,
 - $OH^{-}/(SiO_{1}+GeO_{1}+TO_{1})$: between 3 and 0.01,

- preferably between 1 and 0.03,
- $R/(SiO_2+GeO_2+TO_2)$: between 3 and 0.01, preferably between 1 and 0.03,
- $GeO_2/(SiO_2+GeO_2+TO_2)$: between 0.67 and 0.02, preferably between 0.5 and 0.04,
- $(SiO_2+GeO_2+TO_2)/X_2O_3$: between ∞ and 50, preferably between ∞ and 100, and
- $-\mathrm{TO_2/(SiO_2+GeO_2+TO_2)}$: between 0.15 and 0, preferably between 0.1 and 0.
- 18. A process according to claim 16, wherein the structure directing agent, R, is $1,4-\text{bis}[N-(4-\text{aza},1-\text{azoniumbicyclo}\ [2,2,2]\ \text{octane})$ methyl]benzene hydroxide $(d-\text{DABBz}(OH)_2)$, and wherein the synthesis mixture has a composition expressed in terms of molar ratios in the following intervals:
- $H_2O/(SiO_2+GeO_2+TO_2)$: between 100 and 0.01, preferably between 50 and 0.1
- $OH^{-}/(SiO_2+GeO_2+TO_2)$: between 3 and 0.01, preferably between 1 and 0.03
- $R/(SiO_2+GeO_2+TO_2)$: between 1.5 and 0.005, preferably between 0.5 and 0.015
- $GeO_2/(SiO_2+GeO_2+TO_2)$: between 0.67 and 0.02, preferably between 0.5 and 0.04
- $(SiO_2+GeO_2+TO_2/X_2O_3$: between ∞ and 50, preferably between ∞ and 100,
- $-\ {\rm TO_2/SiO_2 + GeO_2 + TO_2})$: between 0.15 and 0, preferably between 0.1 and 0.
- 19. A process according to claim 16, wherein the synthesis mixture comprises one or more tetravalent elements, T, selected among V, Sn and Ti.
- 20. A process according to claim 16, wherein the source of germanium, silicon and the rest of the tetravalent elements is an oxide.

- 21. A process according to claim 16, wherein the synthesis mixture also comprises a source of one or more trivalent elements, X.
- 22. A process according to claim 11 or 16 that also comprises a step of post-synthesis treatment of the material, whereby the organic component is removed from the structure by means of a technique selected among extraction, roasting and both.
- 23. A material obtained according to the process of claim 22, characterized in that its diffraction diagram has the following as the most important lines:

$2\Theta \pm 0.5$ (degrees)	Intensity (I/Io
6.89	w, m
9.59	vs
21.27	m
21.87	m
27.87	vs